TEXAS INSTRUMENTS

TMUX7219 44V, Latch-Up Immune, 2:1 (SPDT) Precision Switch with 1.8V Logic

1 Features

- Latch-up immune
- Dual supply range: ±4.5V to ±22V
- Single supply range: 4.5V to 44V
- Low on-resistance: 2.1Ω
- Low charge injection: −10pC
- High current support: 330mA (maximum) (VSSOP)
- High current support: 440mA (maximum) (WSON)
- −40°C to +125°C operating temperature
- 1.8V logic compatible
- Fail-safe logic
- Rail-to-rail operation
- Bidirectional signal path
- Break-before-make switching

2 Applications

- Factory automation and industrial controls
- Programmable logic controllers (PLC)
- Analog input modules
- Semiconductor test
- AC charging (Pile) station
- Ultrasound scanners
- Patient monitoring and diagnostics
- Optical networking
- Optical test equipment
- Remote radio units
- Wired networking
- Data acquisition systems
- Gas meters
- Flow transmitters

3 Description

The TMUX7219 is a complementary metal-oxide semiconductor (CMOS) switch with latch-up immunity in a single channel, 2:1 (SPDT) configuration. The device works with a single supply (4.5 V to 44 V), dual supplies (±4.5V to ±22V), or asymmetric supplies (such as V_{DD} = 12V, V_{SS} = –5V). The TMUX7219 supports bidirectional analog and digital signals on the source (Sx) and drain (D) pins ranging from V_{SS} to V_{DD}.

The TMUX7219 can be enabled or disabled by controlling the EN pin. When disabled, both signal path switches are off. When enabled, the SEL pin can be used to turn on signal path 1 (S1 to D) or signal path 2 (S2 to D). All logic control inputs support logic levels from 1.8V to V_{DD}, ensuring both TTL and CMOS logic compatibility when operating in the valid supply voltage range. Fail-Safe Logic circuitry allows voltages on the control pins to be applied before
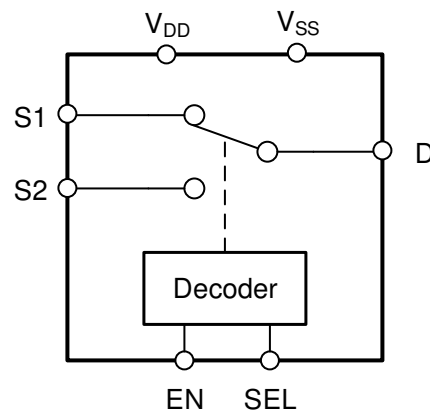
the supply pin, protecting the device from potential damage.

The TMUX72xx family provides latch-up immunity, preventing undesirable high current events between parasitic structures within the device typically caused by overvoltage events. A latch-up condition typically continues until the power supply rails are turned off and can lead to device failure. The latch-up immunity feature allows the TMUX72xx family of switches and multiplexers to be used in harsh environments.

Device Information

PART NUMBER	PACKAGE [1]	BODY SIZE (NOM)
TMUX7219	VSSOP (8) DGK	3.00mm × 3.00mm
	WSON (8) RQX	3.00mm × 2.00mm

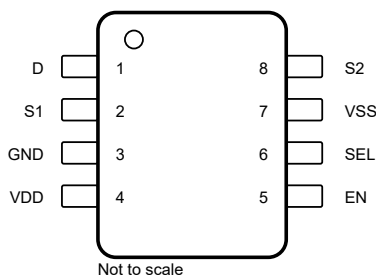(1) For all available packages, see the package option addendum at the end of the data sheet.
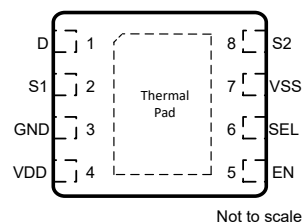

Functional Block Diagram

Table of Contents

4 Pin Configuration and Functions

Figure 4-1. DGK Package,
8-Pin VSSOP
(Top View)

Figure 4-2. RQX Package,
8-Pin WSON
(Top View)

Table 4-1. Pin Functions

PIN			TYPE[1]	DESCRIPTION[2]
NAME	RQX	DGK		
D	1	1	I/O	Drain pin. Can be an input or output.
S1	2	2	I/O	Source pin 1. Can be an input or output.
GND	3	3	P	Ground (0 V) reference
V_{DD}	4	4	P	Positive power supply. This pin is the most positive power-supply potential. For reliable operation, connect a decoupling capacitor ranging from 0.1 µF to 10 µF between V_{DD} and GND.
EN	5	5	I	Active high logic enable, has internal pull-up resistor. When this pin is low, all switches are turned off. When this pin is high, the SEL logic input determine which switch is turned on.
SEL	6	6	I	Logic control input, has internal pull-down resistor. Controls the switch connection as shown in Section 7.5.
V_{SS}	7	7	P	Negative power supply. This pin is the most negative power-supply potential. In single-supply applications, this pin can be connected to ground. For reliable operation, connect a decoupling capacitor ranging from 0.1 µF to 10 µF between V_{SS} and GND.
S2	8	8	I/O	Source pin 2. Can be an input or output.
Thermal Pad	—	—		The thermal pad is not connected internally. There is no requirement to electrically connect this pad. If connected, it is recommended that the pad be left floating or tied to GND.

(1)   I = input, O = output, I/O = input and output, P = power.
(2)   Refer to Section 7.4 for what to do with unused pins.

5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) [1] [2]

		MIN	MAX	UNIT
$V_{DD} - V_{SS}$	Supply voltage		48	V
V_{DD}		−0.5	48	V
V_{SS}		−48	0.5	V
V_{SEL} or V_{EN}	Logic control input pin voltage (SEL, EN)[3]	−0.5	48	V
I_{SEL} or I_{EN}	Logic control input pin current (SEL, EN)[3]	−30	30	mA
V_S or V_D	Source or drain voltage (Sx, D)[3]	V_{SS}–0.5	V_{DD}+0.5	V
I_{IK}	Diode clamp current[3]	−30	30	mA
I_S or $I_{D (CONT)}$	Source or drain continuous current (Sx, D)		I_{DC} + 10 %[4]	mA
T_A	Ambient temperature	−55	150	°C
T_{stg}	Storage temperature	−65	150	°C
T_J	Junction temperature		150	°C
P_{tot}	Total power dissipation (DGK Package)[5]		460	mW
	Total power dissipation (RQX Package) [6]		1110	mW

(1)   Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. *Absolute Maximum Ratings* do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If used outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
(2)   All voltages are with respect to ground, unless otherwise specified.
(3)   Pins are diode-clamped to the power-supply rails. Over voltage signals must be voltage and current limited to maximum ratings.
(4)   Refer to *Source or Drain Continuous Current* table for I_{DC} specifications.
(5)   For DGK package: P_{tot} derates linearly above T_A = 70°C by 6.7mW/°C.
(6)   For RQX package: P_{tot} derates linearly above T_A = 70°C by 16mW/°C.

5.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/ JEDEC JS-001, all pins[1]	±2000	V
		Charged device model (CDM), ANSI/ESDA/ JEDEC JS-002, all pins [2]	±500	

(1)   JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2)   JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

5.3 Thermal Information

THERMAL METRIC[1]		TMUX7219 DGK (VSSOP) 8 PINS	TMUX7219 RQX (WSON) 8 PINS	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance	152.1	62.9	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	48.4	54.0	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	73.2	31.0	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	4.1	0.8	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	71.8	30.9	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	23.4	°C/W

(1)   For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

5.4 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
$V_{DD} - V_{SS}$ [1]	Power supply voltage differential	4.5		44	V
V_{DD}	Positive power supply voltage	4.5		44	V
V_S or V_D	Signal path input/output voltage (source or drain pin) (Sx, D)	V_{SS}		V_{DD}	V
V_{SEL} or V_{EN}	Address or enable pin voltage	0		44	V
I_S or $I_{D (CONT)}$	Source or drain continuous current (Sx, D)			I_{DC} [2]	mA
T_A	Ambient temperature	−40		125	°C

(1) V_{DD} and V_{SS} can be any value as long as 4.5 V ≤ (V_{DD} – V_{SS}) ≤ 44 V, and the minimum V_{DD} is met.
(2)   Refer to *Source or Drain Continuous Current* table for I_{DC} specifications.

5.5 Source or Drain Continuous Current

at supply voltage of V_{DD} ± 10%, V_{SS} ± 10 % (unless otherwise noted)

CONTINUOUS CURRENT PER CHANNEL (I_{DC})		T_A = 25°C	T_A = 85°C	T_A = 125°C	UNIT
PACKAGE	TEST CONDITIONS				
RQX (WSON)	+44 V Single Supply[1]	440	270	130	mA
	±15 V Dual Supply	440	270	130	mA
	+12 V Single Supply	330	200	105	mA
	±5 V Dual Supply	330	200	105	mA
	+5 V Single Supply	230	140	90	mA
DGK (VSSOP)	+44 V Single Supply[1]	330	210	120	mA
	±15 V Dual Supply	330	210	120	mA
	+12 V Single Supply	240	160	100	mA
	±5 V Dual Supply	240	160	100	mA
	+5 V Single Supply	180	120	80	mA

(1)   Specified for nominal supply voltage only.

5.6 ±15 V Dual Supply: Electrical Characteristics

V_{DD} = +15 V ± 10%, V_{SS} = –15 V ±10%, GND = 0 V (unless otherwise noted)

Typical at V_{DD} = +15 V, V_{SS} = –15 V, T_A = 25°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
ANALOG SWITCH							
R_{ON}	On-resistance	V_S = –10 V to +10 V I_D = –10 mA Refer to On-Resistance	25°C		2.1	2.9	Ω
			–40°C to +85°C			3.8	Ω
			–40°C to +125°C			4.5	Ω
ΔR_{ON}	On-resistance mismatch between channels	V_S = –10 V to +10 V I_D = –10 mA Refer to On-Resistance	25°C		0.05	0.25	Ω
			–40°C to +85°C			0.3	Ω
			–40°C to +125°C			0.35	Ω
$R_{ON\ FLAT}$	On-resistance flatness	V_S = –10 V to +10 V I_S = –10 mA Refer to On-Resistance	25°C		0.5	0.6	Ω
			–40°C to +85°C			0.7	Ω
			–40°C to +125°C			0.85	Ω
$R_{ON\ DRIFT}$	On-resistance drift	V_S = 0 V, I_S = –10 mA Refer to On-Resistance	–40°C to +125°C		0.01		Ω/°C
$I_{S(OFF)}$	Source off leakage current[1]	V_{DD} = 16.5 V, V_{SS} = –16.5 V Switch state is off V_S = +10 V / –10 V V_D = –10 V / + 10 V Refer to Off-Leakage Current	25°C	–0.15	0.05	0.15	nA
			–40°C to +85°C	–1.6		1.6	nA
			–40°C to +125°C	–15		15	nA
$I_{D(OFF)}$	Drain off leakage current[1]	V_{DD} = 16.5 V, V_{SS} = –16.5 V Switch state is off V_S = +10 V / –10 V V_D = –10 V / + 10 V Refer to Off-Leakage Current	25°C	–1	0.05	1	nA
			–40°C to +85°C	–3		3	nA
			–40°C to +125°C	–26		26	nA
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current[2]	V_{DD} = 16.5 V, V_{SS} = –16.5 V Switch state is on V_S = V_D = ±10 V Refer to On-Leakage Current	25°C	–1	0.04	1	nA
			–40°C to +85°C	–1.8		1.8	nA
			–40°C to +125°C	–18		18	nA
LOGIC INPUTS (SEL / EN pins)							
V_{IH}	Logic voltage high		–40°C to +125°C	1.3		44	V
V_{IL}	Logic voltage low		–40°C to +125°C	0		0.8	V
I_{IH}	Input leakage current		–40°C to +125°C		0.005	2	µA
I_{IL}	Input leakage current		–40°C to +125°C	–1	–0.005		µA
C_{IN}	Logic input capacitance		–40°C to +125°C		3		pF
POWER SUPPLY							
I_{DD}	V_{DD} supply current	V_{DD} = 16.5 V, V_{SS} = –16.5 V Logic inputs = 0 V, 5 V, or V_{DD}	25°C		30	40	µA
			–40°C to +85°C			48	µA
			–40°C to +125°C			62	µA
I_{SS}	V_{SS} supply current	V_{DD} = 16.5 V, V_{SS} = –16.5 V Logic inputs = 0 V, 5 V, or V_{DD}	25°C		3	10	µA
			–40°C to +85°C			15	µA
			–40°C to +125°C			25	µA

(1)   When V_S is positive, V_D is negative, or when V_S is negative, V_D is positive.
(2)   When V_S is at a voltage potential, V_D is floating, or when V_D is at a voltage potential, V_S is floating.

5.7 ±15 V Dual Supply: Switching Characteristics

V_{DD} = +15 V ± 10%, V_{SS} = –15 V ±10%, GND = 0 V (unless otherwise noted)
Typical at V_{DD} = +15 V, V_{SS} = –15 V, T_A = 25℃ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
t_{TRAN}	Transition time from control input	V_S = 10 V R_L = 300 Ω, C_L = 35 pF Refer to Transition Time	25°C		120	175	ns
			–40°C to +85°C			190	ns
			–40°C to +125°C			210	ns
$t_{ON\ (EN)}$	Turn-on time from enable	V_S = 10 V R_L = 300 Ω, C_L = 35 pF Refer to Turn-on and Turn-off Time	25°C		100	170	ns
			–40°C to +85°C			185	ns
			–40°C to +125°C			200	ns
$t_{OFF\ (EN)}$	Turn-off time from enable	V_S = 10 V R_L = 300 Ω, C_L = 35 pF Refer to Turn-on and Turn-off Time	25°C		100	180	ns
			–40°C to +85°C			195	ns
			–40°C to +125°C			210	ns
t_{BBM}	Break-before-make time delay	V_S = 10 V, R_L = 300 Ω, C_L = 35 pF Refer to Break-Before-Make	25°C		50		ns
			–40°C to +85°C	1			ns
			–40°C to +125°C	1			ns
$T_{ON (VDD)}$	Device turn on time (V_{DD} to output)	V_{DD} rise time = 100ns R_L = 300 Ω, C_L = 35 pF Refer to Turn-on (VDD) Time	25°C		0.19		ms
			–40°C to +85°C		0.2		ms
			–40°C to +125°C		0.2		ms
t_{PD}	Propagation delay	R_L = 50 Ω , C_L = 5 pF Refer to Propagation Delay	25°C		700		ps
Q_{INJ}	Charge injection	V_D = 0 V, C_L = 1 nF Refer to Charge Injection	25°C		–10		pC
O_{ISO}	Off-isolation	R_L = 50 Ω , C_L = 5 pF V_S = 0 V, f = 100 kHz Refer to Off Isolation	25°C		–75		dB
O_{ISO}	Off-isolation	R_L = 50 Ω , C_L = 5 pF V_S = 0 V, f = 1 MHz Refer to Off Isolation	25°C		–55		dB
X_{TALK}	Crosstalk	R_L = 50 Ω , C_L = 5 pF V_S = 0 V, f = 100 kHz Refer to Crosstalk	25°C		–117		dB
X_{TALK}	Crosstalk	R_L = 50 Ω , C_L = 5 pF V_S = 0 V, f = 1MHz Refer to Crosstalk	25°C		–106		dB
BW	–3dB Bandwidth	R_L = 50 Ω , C_L = 5 pF V_S = 0 V Refer to Bandwidth	25°C		40		MHz
I_L	Insertion loss	R_L = 50 Ω , C_L = 5 pF V_S = 0 V, f = 1 MHz	25°C		–0.18		dB
ACPSRR	AC Power Supply Rejection Ratio	V_{PP} = 0.62 V on V_{DD} and V_{SS} R_L = 50 Ω , C_L = 5 pF, f = 1 MHz Refer to ACPSRR	25°C		–64		dB
THD+N	Total Harmonic Distortion + Noise	V_{PP} = 15 V, V_{BIAS} = 0 V R_L = 10 kΩ , C_L = 5 pF, f = 20 Hz to 20 kHz Refer to THD + Noise	25°C		0.0005		%
$C_{S(OFF)}$	Source off capacitance	V_S = 0 V, f = 1 MHz	25°C		33		pF
$C_{D(OFF)}$	Drain off capacitance	V_S = 0 V, f = 1 MHz	25°C		48		pF
$C_{S(ON)}$, $C_{D(ON)}$	On capacitance	V_S = 0 V, f = 1 MHz	25°C		148		pF

Product Folder Links: TMUX7219

5.9 ±20 V Dual Supply: Switching Characteristics

V_{DD} = +20 V ± 10%, V_{SS} = –20 V ±10%, GND = 0 V (unless otherwise noted)
Typical at V_{DD} = +20 V, V_{SS} = –20 V, T_A = 25℃ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
t_{TRAN}	Transition time from control input	V_S = 10 V R_L = 300 Ω, C_L = 35 pF Refer to Transition Time	25°C		110	175	ns
			–40°C to +85°C			190	ns
			–40°C to +125°C			205	ns
$t_{ON\ (EN)}$	Turn-on time from enable	V_S = 10 V R_L = 300 Ω, C_L = 35 pF Refer to Turn-on and Turn-off Time	25°C		110	170	ns
			–40°C to +85°C			185	ns
			–40°C to +125°C			200	ns
$t_{OFF\ (EN)}$	Turn-off time from enable	V_S = 10 V R_L = 300 Ω, C_L = 35 pF Refer to Turn-on and Turn-off Time	25°C		90	180	ns
			–40°C to +85°C			190	ns
			–40°C to +125°C			200	ns
t_{BBM}	Break-before-make time delay	V_S = 10 V, R_L = 300 Ω, C_L = 35 pF Refer to Break-Before-Make	25°C		55		ns
			–40°C to +85°C	1			ns
			–40°C to +125°C	1			ns
$T_{ON\ (VDD)}$	Device turn on time (V_{DD} to output)	V_{DD} rise time = 100ns R_L = 300 Ω, C_L = 35 pF Refer to Turn-on (VDD) Time	25°C		0.18		ms
			–40°C to +85°C		0.2		ms
			–40°C to +125°C		0.2		ms
t_{PD}	Propagation delay	R_L = 50 Ω , C_L = 5 pF Refer to Propagation Delay	25°C		715		ps
Q_{INJ}	Charge injection	V_D = 0 V, C_L = 1 nF Refer to Charge Injection	25°C		–15		pC
O_{ISO}	Off-isolation	R_L = 50 Ω , C_L = 5 pF V_S = 0 V, f = 100 kHz Refer to Off Isolation	25°C		–75		dB
O_{ISO}	Off-isolation	R_L = 50 Ω , C_L = 5 pF V_S = 0 V, f = 1 MHz Refer to Off Isolation	25°C		–55		dB
X_{TALK}	Crosstalk	R_L = 50 Ω , C_L = 5 pF V_S = 0 V, f = 100 kHz Refer to Crosstalk	25°C		–117		dB
X_{TALK}	Crosstalk	R_L = 50 Ω , C_L = 5 pF V_S = 0 V, f = 1MHz Refer to Crosstalk	25°C		–106		dB
BW	–3dB Bandwidth	R_L = 50 Ω , C_L = 5 pF V_S = 0 V, Refer to Bandwidth	25°C		38		MHz
I_L	Insertion loss	R_L = 50 Ω , C_L = 5 pF V_S = 0 V, f = 1 MHz	25°C		–0.16		dB
ACPSRR	AC Power Supply Rejection Ratio	V_{PP} = 0.62 V on V_{DD} and V_{SS} R_L = 50 Ω , C_L = 5 pF, f = 1 MHz Refer to ACPSRR	25°C		–63		dB
THD+N	Total Harmonic Distortion + Noise	V_{PP} = 20 V, V_{BIAS} = 0 V R_L = 10 kΩ , C_L = 5 pF, f = 20 Hz to 20 kHz Refer to THD + Noise	25°C		0.0005		%
$C_{S(OFF)}$	Source off capacitance	V_S = 0 V, f = 1 MHz	25°C		32		pF
$C_{D(OFF)}$	Drain off capacitance	V_S = 0 V, f = 1 MHz	25°C		45		pF
$C_{S(ON)}$, $C_{D(ON)}$	On capacitance	V_S = 0 V, f = 1 MHz	25°C		146		pF

5.10 44 V Single Supply: Electrical Characteristics

V_{DD} = +44 V, V_{SS} = 0 V, GND = 0 V (unless otherwise noted)
Typical at V_{DD} = +44 V, V_{SS} = 0 V, T_A = 25℃ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
ANALOG SWITCH							
R_{ON}	On-resistance	V_S = 0 V to 40 V I_D = –10 mA Refer to On-Resistance	25°C		2.2	2.8	Ω
			–40°C to +85°C			3.6	Ω
			–40°C to +125°C			4.2	Ω
ΔR_{ON}	On-resistance mismatch between channels	V_S = 0 V to 40 V I_D = –10 mA Refer to On-Resistance	25°C		0.1	0.2	Ω
			–40°C to +85°C			0.3	Ω
			–40°C to +125°C			0.35	Ω
$R_{ON\ FLAT}$	On-resistance flatness	V_S = 0 V to 40 V I_D = –10 mA Refer to On-Resistance	25°C		0.2	1	Ω
			–40°C to +85°C			1.3	Ω
			–40°C to +125°C			1.5	Ω
$R_{ON\ DRIFT}$	On-resistance drift	V_S = 22 V, I_S = –10 mA Refer to On-Resistance	–40°C to +125°C		0.008		Ω/°C
$I_{S(OFF)}$	Source off leakage current[1]	V_{DD} = 44 V, V_{SS} = 0 V Switch state is off V_S = 40 V / 1 V V_D = 1 V / 40 V Refer to Off-Leakage Current	25°C	–5	0.05	5	nA
			–40°C to +85°C	–10		10	nA
			–40°C to +125°C	–35		35	nA
$I_{D(OFF)}$	Drain off leakage current[1]	V_{DD} = 44 V, V_{SS} = 0 V Switch state is off V_S = 40 V / 1 V V_D = 1 V / 40 V Refer to Off-Leakage Current	25°C	–8	0.05	8	nA
			–40°C to +85°C	–12		12	nA
			–40°C to +125°C	–70		70	nA
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current[2]	V_{DD} = 44 V, V_{SS} = 0 V Switch state is on V_S = V_D = 40 V or 1 V Refer to On-Leakage Current	25°C	–8	0.05	8	nA
			–40°C to +85°C	–10		10	nA
			–40°C to +125°C	–45		45	nA
LOGIC INPUTS (SEL / EN pins)							
V_{IH}	Logic voltage high		–40°C to +125°C	1.3		44	V
V_{IL}	Logic voltage low		–40°C to +125°C	0		0.8	V
I_{IH}	Input leakage current		–40°C to +125°C		0.005	2	µA
I_{IL}	Input leakage current		–40°C to +125°C	–1	–0.005		µA
C_{IN}	Logic input capacitance		–40°C to +125°C		3		pF
POWER SUPPLY							
I_{DD}	V_{DD} supply current	V_{DD} = 44 V, V_{SS} = 0 V Logic inputs = 0 V, 5 V, or V_{DD}	25°C		17	50	µA
			–40°C to +85°C			60	µA
			–40°C to +125°C			75	µA

(1) When V_S is 40V, V_D is 1V, or when V_S is 1V, V_D is 40V.
(2) When V_S is at a voltage potential, V_D is floating, or when V_D is at a voltage potential, V_S is floating.

5.11 44 V Single Supply: Switching Characteristics

V_{DD} = +44 V, V_{SS} = 0 V, GND = 0 V (unless otherwise noted)
Typical at V_{DD} = +44 V, V_{SS} = 0 V, T_A = 25℃ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
t_{TRAN}	Transition time from control input	V_S = 18 V R_L = 300 Ω, C_L = 35 pF Refer to Transition Time	25°C		120	175	ns
			–40°C to +85°C			190	ns
			–40°C to +125°C			205	ns
$t_{ON\ (EN)}$	Turn-on time from enable	V_S = 18 V R_L = 300 Ω, C_L = 35 pF Refer to Turn-on and Turn-off Time	25°C		120	168	ns
			–40°C to +85°C			185	ns
			–40°C to +125°C			195	ns
$t_{OFF\ (EN)}$	Turn-off time from enable	V_S = 18 V R_L = 300 Ω, C_L = 35 pF Refer to Turn-on and Turn-off Time	25°C		120	180	ns
			–40°C to +85°C			200	ns
			–40°C to +125°C			205	ns
t_{BBM}	Break-before-make time delay	V_S = 18 V, R_L = 300 Ω, C_L = 35 pF Refer to Break-Before-Make	25°C		45		ns
			–40°C to +85°C	1			ns
			–40°C to +125°C	1			ns
$T_{ON\ (VDD)}$	Device turn on time (V_{DD} to output)	V_{DD} rise time = 1µs R_L = 300 Ω, C_L = 35 pF Refer to Turn-on (VDD) Time	25°C		0.15		ms
			–40°C to +85°C		0.17		ms
			–40°C to +125°C		0.17		ms
t_{PD}	Propagation delay	R_L = 50 Ω , C_L = 5 pF Refer to Propagation Delay	25°C		930		ps
Q_{INJ}	Charge injection	V_D = 22 V, C_L = 1 nF Refer to Charge Injection	25°C		–16		pC
O_{ISO}	Off-isolation	R_L = 50 Ω , C_L = 5 pF V_S = 6 V, f = 100 kHz Refer to Off Isolation	25°C		–75		dB
O_{ISO}	Off-isolation	R_L = 50 Ω , C_L = 5 pF V_S = 6 V, f = 1 MHz Refer to Off Isolation	25°C		–55		dB
X_{TALK}	Crosstalk	R_L = 50 Ω , C_L = 5 pF V_S = 6 V, f = 100 kHz Refer to Crosstalk	25°C		–117		dB
X_{TALK}	Crosstalk	R_L = 50 Ω , C_L = 5 pF V_S = 6 V, f = 1MHz Refer to Crosstalk	25°C		–106		dB
BW	–3dB Bandwidth	R_L = 50 Ω , C_L = 5 pF V_S = 6 V Refer to Bandwidth	25°C		37		MHz
I_L	Insertion loss	R_L = 50 Ω , C_L = 5 pF V_S = 6 V, f = 1 MHz	25°C		–0.18		dB
ACPSRR	AC Power Supply Rejection Ratio	V_{PP} = 0.62 V on V_{DD} and V_{SS} R_L = 50 Ω , C_L = 5 pF, f = 1 MHz Refer to ACPSRR	25°C		–60		dB
THD+N	Total Harmonic Distortion + Noise	V_{PP} = 22 V, V_{BIAS} = 22 V R_L = 10 kΩ , C_L = 5 pF, f = 20 Hz to 20 kHz Refer to THD + Noise	25°C		0.0004		%
$C_{S(OFF)}$	Source off capacitance	V_S = 6 V, f = 1 MHz	25°C		34		pF
$C_{D(OFF)}$	Drain off capacitance	V_S = 6 V, f = 1 MHz	25°C		48		pF
$C_{S(ON)},$ $C_{D(ON)}$	On capacitance	V_S = 6 V, f = 1 MHz	25°C		146		pF

Product Folder Links: TMUX7219

5.12 12 V Single Supply: Electrical Characteristics

V_{DD} = +12 V ± 10%, V_{SS} = 0 V, GND = 0 V (unless otherwise noted)
Typical at V_{DD} = +12 V, V_{SS} = 0 V, T_A = 25℃ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
ANALOG SWITCH							
R_{ON}	On-resistance	V_S = 0 V to 10 V I_D = –10 mA Refer to On-Resistance	25°C		4.6	6	Ω
			–40°C to +85°C			7.5	Ω
			–40°C to +125°C			8.4	Ω
ΔR_{ON}	On-resistance mismatch between channels	V_S = 0 V to 10 V I_D = –10 mA Refer to On-Resistance	25°C		0.08	0.2	Ω
			–40°C to +85°C			0.32	Ω
			–40°C to +125°C			0.35	Ω
$R_{ON\ FLAT}$	On-resistance flatness	V_S = 0 V to 10 V I_S = –10 mA Refer to On-Resistance	25°C		1.2	2	Ω
			–40°C to +85°C			2.2	Ω
			–40°C to +125°C			2.4	Ω
$R_{ON\ DRIFT}$	On-resistance drift	V_S = 6 V, I_S = –10 mA Refer to On-Resistance	–40°C to +125°C		0.017		Ω/°C
$I_{S(OFF)}$	Source off leakage current[1]	V_{DD} = 13.2 V, V_{SS} = 0 V Switch state is off V_S = 10 V / 1 V V_D = 1 V / 10 V Refer to Off-Leakage Current	25°C	–0.5	0.05	0.5	nA
			–40°C to +85°C	–2		2	nA
			–40°C to +125°C	–12		12	nA
$I_{D(OFF)}$	Drain off leakage current[1]	V_{DD} = 13.2 V, V_{SS} = 0 V Switch state is off V_S = 10 V / 1 V V_D = 1 V / 10 V Refer to Off-Leakage Current	25°C	–0.5	0.05	0.5	nA
			–40°C to +85°C	–3		3	nA
			–40°C to +125°C	–23		23	nA
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current[2]	V_{DD} = 13.2 V, V_{SS} = 0 V Switch state is on V_S = V_D = 10 V or 1 V Refer to On-Leakage Current	25°C	–1.5	0.05	1.5	nA
			–40°C to +85°C	–3		3	nA
			–40°C to +125°C	–15		15	nA
LOGIC INPUTS (SEL / EN pins)							
V_{IH}	Logic voltage high		–40°C to +125°C	1.3		44	V
V_{IL}	Logic voltage low		–40°C to +125°C	0		0.8	V
I_{IH}	Input leakage current		–40°C to +125°C		0.005	2	µA
I_{IL}	Input leakage current		–40°C to +125°C	–1	–0.005		µA
C_{IN}	Logic input capacitance		–40°C to +125°C		3		pF
POWER SUPPLY							
I_{DD}	V_{DD} supply current	V_{DD} = 13.2 V, V_{SS} = 0 V Logic inputs = 0 V, 5 V, or V_{DD}	25°C		10	35	µA
			–40°C to +85°C			45	µA
			–40°C to +125°C			55	µA

(1)   When V_S is 10V, V_D is 1V, or when V_S is 1V, V_D is 10V.
(2)   When V_S is at a voltage potential, V_D is floating, or when V_D is at a voltage potential, V_S is floating.

5.13 12 V Single Supply: Switching Characteristics

V_{DD} = +12 V ± 10%, V_{SS} = 0 V, GND = 0 V (unless otherwise noted)
Typical at V_{DD} = +12 V, V_{SS} = 0 V, T_A = 25℃ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
t_{TRAN}	Transition time from control input	V_S = 8 V R_L = 300 Ω, C_L = 35 pF Refer to Transition Time	25°C		180	185	ns
			–40°C to +85°C			215	ns
			–40°C to +125°C			235	ns
$t_{ON (EN)}$	Turn-on time from enable	V_S = 8 V R_L = 300 Ω, C_L = 35 pF Refer to Turn-on and Turn-off Time	25°C		120	180	ns
			–40°C to +85°C			210	ns
			–40°C to +125°C			230	ns
$t_{OFF (EN)}$	Turn-off time from enable	V_S = 8 V R_L = 300 Ω, C_L = 35 pF Refer to Turn-on and Turn-off Time	25°C		130	210	ns
			–40°C to +85°C			235	ns
			–40°C to +125°C			250	ns
t_{BBM}	Break-before-make time delay	V_S = 8 V, R_L = 300 Ω, C_L = 35 pF Refer to Break-Before-Make	25°C		40		ns
			–40°C to +85°C	1			ns
			–40°C to +125°C	1			ns
$T_{ON (VDD)}$	Device turn on time (V_{DD} to output)	V_{DD} rise time = 100ns R_L = 300 Ω, C_L = 35 pF Refer to Turn-on (VDD) Time	25°C		0.19		ms
			–40°C to +85°C		0.2		ms
			–40°C to +125°C		0.2		ms
t_{PD}	Propagation delay	R_L = 50 Ω , C_L = 5 pF Refer to Propagation Delay	25°C		740		ps
Q_{INJ}	Charge injection	V_D = 6 V, C_L = 1 nF Refer to Charge Injection	25°C		–6		pC
O_{ISO}	Off-isolation	R_L = 50 Ω , C_L = 5 pF V_S = 6 V, f = 100 kHz Refer to Off Isolation	25°C		–75		dB
O_{ISO}	Off-isolation	R_L = 50 Ω , C_L = 5 pF V_S = 6 V, f = 1 MHz Refer to Off Isolation	25°C		–55		dB
X_{TALK}	Crosstalk	R_L = 50 Ω , C_L = 5 pF V_S = 6 V, f = 100 kHz Refer to Crosstalk	25°C		–117		dB
X_{TALK}	Crosstalk	R_L = 50 Ω , C_L = 5 pF V_S = 6 V, f = 1MHz Refer to Crosstalk	25°C		–106		dB
BW	–3dB Bandwidth	R_L = 50 Ω , C_L = 5 pF V_S = 6 V Refer to Bandwidth	25°C		42		MHz
I_L	Insertion loss	R_L = 50 Ω , C_L = 5 pF V_S = 6 V, f = 1 MHz	25°C		–0.3		dB
ACPSRR	AC Power Supply Rejection Ratio	V_{PP} = 0.62 V on V_{DD} and V_{SS} R_L = 50 Ω , C_L = 5 pF, f = 1 MHz Refer to ACPSRR	25°C		–65		dB
THD+N	Total Harmonic Distortion + Noise	V_{PP} = 6 V, V_{BIAS} = 6 V R_L = 10 kΩ , C_L = 5 pF, f = 20 Hz to 20 kHz Refer to THD + Noise	25°C		0.0009		%
$C_{S(OFF)}$	Source off capacitance	V_S = 6 V, f = 1 MHz	25°C		38		pF
$C_{D(OFF)}$	Drain off capacitance	V_S = 6 V, f = 1 MHz	25°C		56		pF
$C_{S(ON)}$, $C_{D(ON)}$	On capacitance	V_S = 6 V, f = 1 MHz	25°C		150		pF

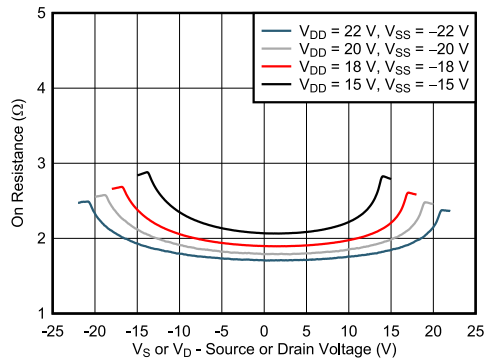## 5.14 Typical Characteristics

at T_A = 25°C

Figure 5-1. On-Resistance vs Source or Drain Voltage – Dual Supply
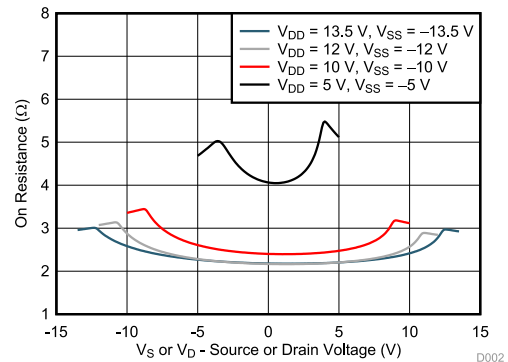

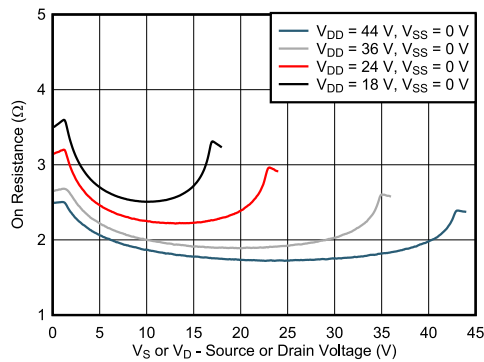**Figure 5-2. On-Resistance vs Source or Drain Voltage – Dual Supply**

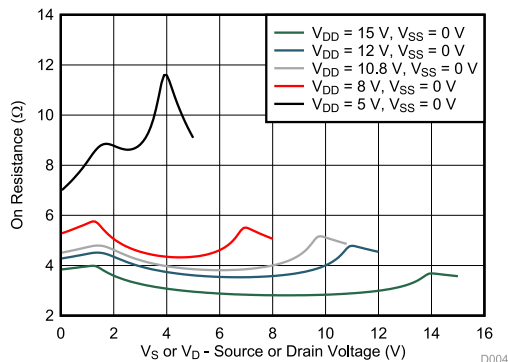**Figure 5-3. On-Resistance vs Source or Drain Voltage – Single Supply**

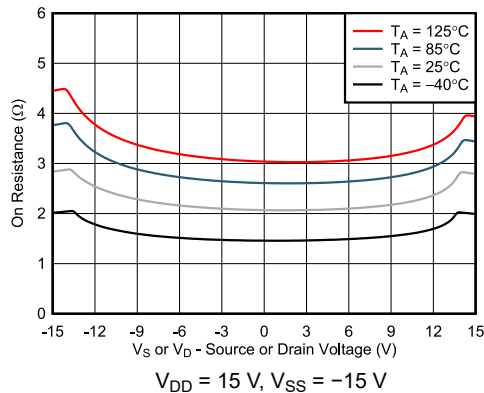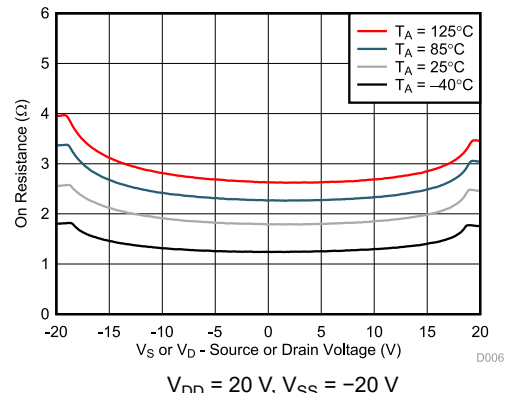**Figure 5-4. On-Resistance vs Source or Drain Voltage – Single Supply**

V_{DD} = 15 V, V_{SS} = −15 V

Figure 5-5. On-Resistance vs Temperature

V_{DD} = 20 V, V_{SS} = −20 V

Figure 5-6. On-Resistance vs Temperature

Product Folder Links: *TMUX7219*

5.14 Typical Characteristics (continued)

at T_A = 25°C

V_{DD} = 5 V, V_{SS} = −5 V

Figure 5-7. On-Resistance vs Temperature

V_{DD} = 12 V, V_{SS} = 0 V

Figure 5-8. On-Resistance vs Temperature

V_{DD} = 36 V, V_{SS} = 0 V

Figure 5-9. On-Resistance vs Temperature

V_{DD} = 20 V, V_{SS} = −20 V

Figure 5-10. Leakage Current vs Temperature

V_{DD} = 15 V, V_{SS} = −15 V

Figure 5-11. Leakage Current vs Temperature

V_{DD} = 36 V, V_{SS} = 0 V

Figure 5-12. Leakage Current vs Temperature

Product Folder Links: *TMUX7219*

5.14 Typical Characteristics (continued)

at $T_A = 25°C$

$V_{DD} = 12$ V, $V_{SS} = 0$ V

Figure 5-13. Leakage Current vs Temperature
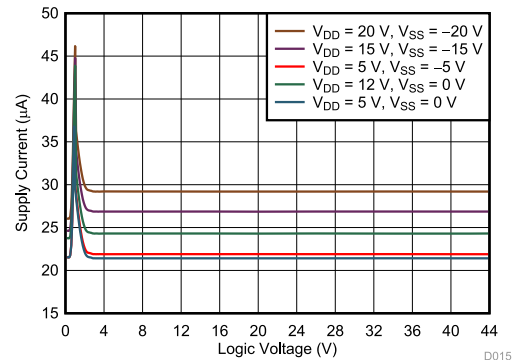

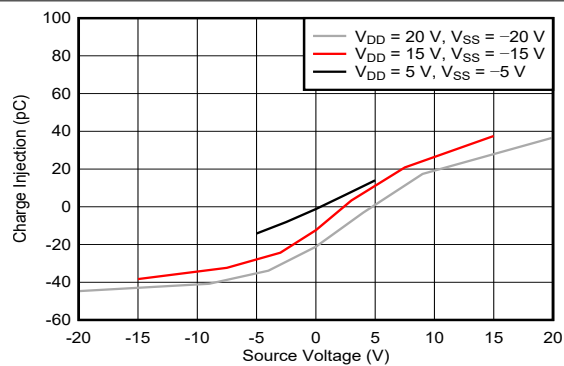**Figure 5-14. Supply Current vs Logic Voltage**

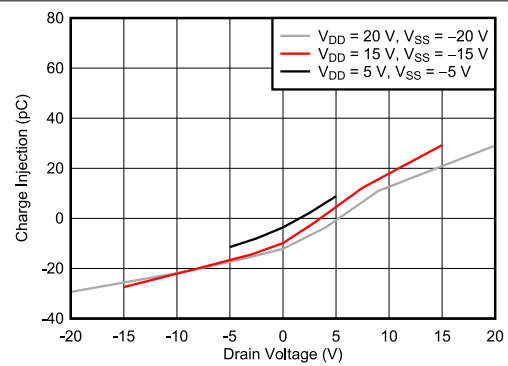**Figure 5-15. Charge Injection vs Source Voltage – Dual Supply**

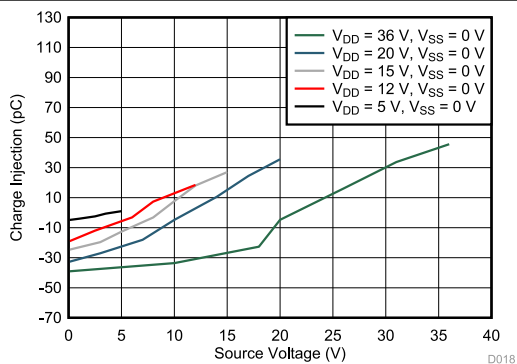**Figure 5-16. Charge Injection vs Drain Voltage – Dual Supply**

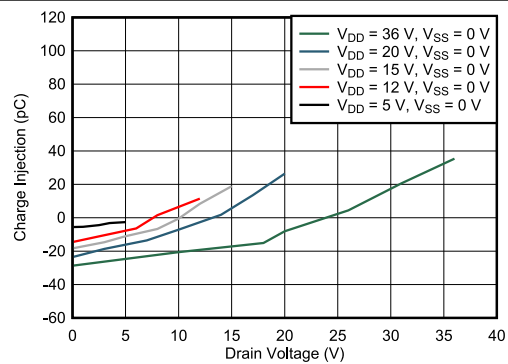**Figure 5-17. Charge Injection vs Source Voltage – Single Supply**

Figure 5-18. Charge Injection vs Drian Voltage – Single Supply

Product Folder Links: *TMUX7219*

5.14 Typical Characteristics (continued)

at T_A = 25°C

V_{DD} = 15 V, V_{SS} = −15 V

Figure 5-19. T$_{TRANSITION}$ vs Temperature

V_{DD} = 44 V, V_{SS} = 0 V

Figure 5-20. T$_{TRANSITION}$ vs Temperature

V_{DD} = 15 V, V_{SS} = −15 V

Figure 5-21. T$_{ON}$ and T$_{OFF}$ vs Temperature
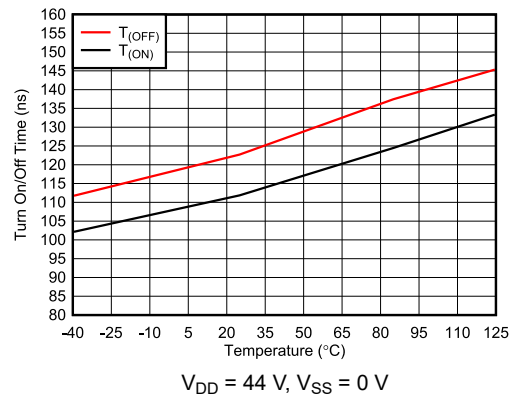

V_{DD} = 44 V, V_{SS} = 0 V

Figure 5-22. T$_{ON}$ and T$_{OFF}$ vs Temperature

Figure 5-23. Off-Isolation vs Frequency

Switch *ON* (EN = 1)

Figure 5-24. Crosstalk vs Frequency

Product Folder Links: *TMUX7219*

5.14 Typical Characteristics (continued)

at T_A = 25°C

Switch *OFF* (EN = 0)

Figure 5-25. Crosstalk vs Frequency

Figure 5-26. THD+N vs Frequency (Dual Supply)

Figure 5-27. THD+N vs Frequency (Single Supply)

V_{DD} = 15 V, V_{SS} = −15 V

Figure 5-28. On Response vs Frequency

V_{DD} = +15 V, V_{SS} = −15 V

Figure 5-29. ACPSRR vs Frequency

V_{DD} = +15 V, V_{SS} = −15 V

Figure 5-30. Capacitance vs Source Voltage or Drain Voltage

Product Folder Links: *TMUX7219*

5.14 Typical Characteristics (continued)

at T_A = 25°C

V_{DD} = 12 V, V_{SS} = 0 V

Figure 5-31. Capacitance vs Source Voltage or Drain Voltage

Product Folder Links: *TMUX7219*

6 Parameter Measurement Information

6.1 On-Resistance

The on-resistance of a device is the ohmic resistance between the source (Sx) and drain (D) pins of the device. The on-resistance varies with input voltage and supply voltage. The symbol R_{ON} is used to denote on-resistance. Figure 6-1 shows the measurement setup used to measure R_{ON}. Voltage (V) and current (I_{SD}) are measured using the following setup, where R_{ON} is computed as $R_{ON} = V / I_{SD}$:

Figure 6-1. On-Resistance

6.2 Off-Leakage Current

There are two types of leakage currents associated with a switch during the off state:

1. Source off-leakage current.
2. Drain off-leakage current.

Source leakage current is defined as the leakage current flowing into or out of the source pin when the switch is off. This current is denoted by the symbol $I_{S(OFF)}$.

Drain leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is off. This current is denoted by the symbol $I_{D(OFF)}$.

Figure 6-2 shows the setup used to measure both off-leakage currents.

Figure 6-2. Off-Leakage Measurement Setup

6.3 On-Leakage Current

Source on-leakage current is defined as the leakage current flowing into or out of the source pin when the switch is on. This current is denoted by the symbol $I_{S(ON)}$.

Drain on-leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is on. This current is denoted by the symbol $I_{D(ON)}$.

Either the source pin or drain pin is left floating during the measurement. Figure 6-3 shows the circuit used for measuring the on-leakage current, denoted by $I_{S(ON)}$ or $I_{D(ON)}$.

Figure 6-3. On-Leakage Measurement Setup

6.4 Transition Time

Transition time is defined as the time taken by the output of the device to rise or fall 90% after the address signal has risen or fallen past the logic threshold. The 90% transition measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance. Figure 6-4 shows the setup used to measure transition time, denoted by the symbol $t_{TRANSITION}$.

Figure 6-4. Transition-Time Measurement Setup

6.5 $t_{ON(EN)}$ and $t_{OFF(EN)}$

Turn-on time is defined as the time taken by the output of the device to rise to 90% after the enable has risen past the logic threshold. The 90% measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance. Figure 6-5 shows the setup used to measure turn-on time, denoted by the symbol $t_{ON(EN)}$.

Turn-off time is defined as the time taken by the output of the device to fall to 10% after the enable has fallen past the logic threshold. The 10% measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance. Figure 6-5 shows the setup used to measure turn-off time, denoted by the symbol $t_{OFF(EN)}$.

Figure 6-5. Turn-On and Turn-Off Time Measurement Setup

6.6 Break-Before-Make

Break-before-make delay is a safety feature that prevents two inputs from connecting when the device is switching. The output first breaks from the on-state switch before making the connection with the next on-state switch. The time delay between the *break* and the *make* is known as break-before-make delay. Figure 6-6 shows the setup used to measure break-before-make delay, denoted by the symbol $t_{OPEN(BBM)}$.

Figure 6-6. Break-Before-Make Delay Measurement Setup

Product Folder Links: *TMUX7219*

6.7 $t_{ON\ (VDD)}$ Time

The $t_{ON\ (VDD)}$ time is defined as the time taken by the output of the device to rise to 90% after the supply has risen past the supply threshold. The 90% measurement is used to provide the timing of the device turning on in the system. Figure 6-7 shows the setup used to measure turn on time, denoted by the symbol $t_{ON\ (VDD)}$.

Figure 6-7. $t_{ON\ (VDD)}$ Time Measurement Setup

6.8 Propagation Delay

Propagation delay is defined as the time taken by the output of the device to rise or fall 50% after the input signal has risen or fallen past the 50% threshold. Figure 6-8 shows the setup used to measure propagation delay, denoted by the symbol t_{PD}.

Figure 6-8. Propagation Delay Measurement Setup

6.9 Charge Injection

The TMUX7219 has a transmission-gate topology. Any mismatch in capacitance between the NMOS and PMOS transistors results in a charge injected into the drain or source during the falling or rising edge of the gate signal. The amount of charge injected into the source or drain of the device is known as charge injection, and is denoted by the symbol Q_C. Figure 6-9 shows the setup used to measure charge injection from source (Sx) to drain (D).

Figure 6-9. Charge-Injection Measurement Setup

6.10 Off Isolation

Off isolation is defined as the ratio of the signal at the drain pin (D) of the device when a signal is applied to the source pin (Sx) of an off-channel. Figure 6-10 shows the setup used to measure, and the equation used to calculate off isolation.

$$\text{Off Isolation} = 20 \times \text{Log} \frac{V_{OUT}}{V_S}$$

Figure 6-10. Off Isolation Measurement Setup

6.11 Crosstalk

Crosstalk is defined as the ratio of the signal at the drain pin (D) of a different channel, when a signal is applied at the source pin (Sx) of an on-channel. Figure 6-11 shows the setup used to measure, and the equation used to calculate crosstalk.

$$\text{Crosstalk} = 20 \times \text{Log} \frac{V_{OUT}}{V_S}$$

Figure 6-11. Crosstalk Measurement Setup

6.12 Bandwidth

Bandwidth is defined as the range of frequencies that are attenuated by less than 3 dB when the input is applied to the source pin (Sx) of an on-channel, and the output is measured at the drain pin (D) of the device. Figure 6-12 shows the setup used to measure bandwidth.

$$\text{Bandwidth} = 20 \times \text{Log} \frac{V_{OUT}}{V_S}$$

Figure 6-12. Bandwidth Measurement Setup

Product Folder Links: *TMUX7219*

6.13 THD + Noise

The total harmonic distortion (THD) of a signal is a measurement of the harmonic distortion, and is defined as the ratio of the sum of the powers of all harmonic components to the power of the fundamental frequency at the mux output.

The on-resistance of the device varies with the amplitude of the input signal and results in distortion when the drain pin is connected to a low-impedance load. Total harmonic distortion plus noise is denoted as THD + N.

Figure 6-13. THD + N Measurement Setup

6.14 Power Supply Rejection Ratio (PSRR)

PSRR measures the ability of a device to prevent noise and spurious signals that appear on the supply voltage pin from coupling to the output of the switch. The DC voltage on the device supply is modulated by a sine wave of 620 mV$_{PP}$. The ratio of the amplitude of signal on the output to the amplitude of the modulated signal is the ACPSRR. A high ratio represents a high degree of tolerance to supply rail variation.

This helps stabilize the supply and immediately filter as much of the supply noise as possible.

Product Folder Links: *TMUX7219*

$$PSRR = 20 \times Log \frac{V_{OUT}}{V_{IN}}$$

Figure 6-14. ACPSRR Measurement Setup

7 Detailed Description

7.1 Overview

The TMUX7219 is a 2:1, 1-channel switch. Each input is turned on or turned off based on the state of the select line and enable pin.

7.2 Functional Block Diagram

The following figure shows the functional block diagram of the TMUX7219.

7.3 Feature Description

7.3.1 Bidirectional Operation

The TMUX7219 conducts equally well from source (Sx) to drain (D) or from drain (D) to source (Sx). Each channel has very similar characteristics in both directions and supports both analog and digital signals.

7.3.2 Rail-to-Rail Operation

The valid signal path input and output voltage for TMUX7219 ranges from V_{SS} to V_{DD}.

7.3.3 1.8 V Logic Compatible Inputs

The TMUX7219 has 1.8 V logic compatible control for all logic control inputs. 1.8 V logic level inputs allows the device to interface with processors that have lower logic I/O rails and eliminates the need for an external translator, which saves both space and BOM cost. For more information on 1.8 V logic implementations refer to *Simplifying Design with 1.8 V logic Muxes and Switches*.

7.3.4 Integrated Pull-Up and Pull-Down Resistor on Logic Pins

The TMUX7219 has internal weak pull-up and pull-down resistors to GND to ensure the logic pins are not left floating. The value of this pull-down resistor is approximately 4 MΩ, but is clamped to about 1 µA at higher voltages. The EN pin integrates a pull-up resistor to V_{DD} and the SEL pin integrates a pull-down resistor. This feature integrates up to two external components and reduces system size and cost.

7.3.5 Fail-Safe Logic

The TMUX7219 supports Fail-Safe Logic on the control input pins (EN and SEL) allowing for operation up to 44 V above ground, regardless of the state of the supply pins. This feature allows voltages on the control pins to be applied before the supply pin, protecting the device from potential damage. Fail-Safe Logic minimizes system complexity by removing the need for power supply sequencing on the logic control pins. For example, the Fail-Safe Logic feature allows the logic input pins of the TMUX7219 to be ramped to +44 V while V_{DD} and V_{SS} = 0 V. The logic control inputs are protected against positive faults of up to +44 V in powered-off condition, but do not offer protection against negative overvoltage conditions.

7.3.6 Latch-Up Immune

Latch-up is a condition where a low impedance path is created between a supply pin and ground. This condition is caused by a trigger (current injection or overvoltage), but once activated, the low impedance path remains even after the trigger is no longer present. This low impedance path may cause system upset or catastrophic damage due to excessive current levels. The latch-up condition typically requires a power cycle to eliminate the low impedance path.

The TMUX72xx family of devices are constructed on Silicon on Insulator (SOI) based process where an oxide layer is added between the PMOS and NMOS transistor of each CMOS switch to prevent parasitic structures from forming. The oxide layer is also known as an insulating trench and prevents triggering of latch up events due to overvoltage or current injections. The latch-up immunity feature allows the TMUX72xx family of switches and multiplexers to be used in harsh environments. For more information on latch-up immunity refer to *Using Latch Up Immune Multiplexers to Help Improve System Reliability*.

7.3.7 Ultra-Low Charge Injection

Figure 7-1 shows how the TMUX7219 has a transmission gate topology. Any mismatch in the stray capacitance associated with the NMOS and PMOS causes an output level change whenever the switch is opened or closed.

Figure 7-1. Transmission Gate Topology

The TMUX7219 contains specialized architecture to reduce charge injection on the source (Sx). To further reduce charge injection in a sensitive application, a compensation capacitor (Cp) can be added on the drain (D). This will ensure that excess charge from the switch transition will be pushed into the compensation capacitor on the drain (D) instead of the source (Sx). As a general rule, Cp should be 20× larger than the equivalent load capacitance on the source (Sx). Figure 7-2 shows charge injection variation with source voltage with different compensation capacitors on the drain side.

Figure 7-2. Charge Injection Compensation

7.4 Device Functional Modes

When the EN pin of the TMUX7219 is pulled high, one of the switches is closed based on the state of the SEL pin. When the EN pin is pulled low, both of the switches are in an open state regardless of the state of the SEL pin. The control pins can be as high as 44 V.

The TMUX7219 can operate without any external components except for the supply decoupling capacitors. The EN pin has an internal pull-up resistor of 4 MΩ, and SEL pin has internal pull-down resistor of 4 MΩ. If unused, EN pin must be tied to V_{DD} and SEL pin must be tied to GND to ensure the device does not consume additional current as highlighted in Implications of Slow or Floating CMOS Inputs. Unused signal path inputs (S1, S2, or D) should be connected to GND.

7.5 Truth Tables

Table 7-1 show the truth tables for the TMUX7219.

Table 7-1. TMUX7219 Truth Table

EN	SEL	Selected Source Connected To Drain (D) Pin
0	X[1]	All sources are off (HI-Z)
1	0	S1
1	1	S2

(1)   X denotes *do not care*.

Product Folder Links: *TMUX7219*

8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

TMUX7219 is part of the precision switches and multiplexers family of devices. TMUX7219 offers low RON, low on and off leakage currents, and ultra-low charge injection performance. These properties make TMUX7219 ideal for implementing high precision industrial systems requiring selection of one of two inputs or outputs.

8.2 Typical Applications

8.2.1 Power Amplifier Gate Driver

One application of the TMUX7219 is for input control of a power amplifier gate driver. Utilizing a switch allows a system to control when the DAC is connected to the power amplifier, and can stop biasing the power amplifier by switching the gate to V_{SS}. The wide dual supply range of ±4.5 V to ±22 V allows the switch to work with GaN power amplifiers and the wide single supply range 4.5 V to 44 V works well with LDMOS power amplifiers.

Figure 8-1 shows the TMUX7219 configured for control of the power amplifier gate driver in GaN application.

Figure 8-1. Power Amplifier Gate Driver

8.2.1.1 Design Requirements

For this design example, use the parameters listed in Table 8-1.

Table 8-1. Design Parameters

PARAMETERS	VALUES	
	GAN Application	**LDMOS Application**
Supply (V_{DD})	8 V	5 V
Supply (V_{SS})	−12 V	0 V
MUX I/O signal range	−12 V to 8 V (Rail-to-Rail)	0 V to 5 V (Rail-to-Rail)
Control logic thresholds	1.8 V compatiable (up to V_{DD})	1.8 V compatiable (up to V_{DD})
EN	EN pulled high to enable the switch	EN pulled high to enable the switch

8.2.1.2 Detailed Design Procedure

The application shown in Figure 8-1 demonstrates how to toggle between the DAC output and low signal voltage for control of a GaN power amplifier using a single control input. The DAC output is utilized to bias the gate of the power amplifier and can be disconnected from the circuit using the select pin of the switch. The TMUX7219 can support 1.8 V logic signals on the control input, allowing the device to interface with low logic controls of an FPGA or MCU. The TMUX7219 can operate without any external components except for the supply decoupling capacitors. The select pin has an internal pull-down resistor to prevent floating input logic. All inputs to the switch must fall within the recommended operating conditions of the TMUX7219 including signal range and continuous current. For this design with a positive supply of 8 V on V_{DD} and negative supply of −12 V on V_{SS}, the signal range can be 8 V to −12 V. The maximum continuous current (I_{DC}) can be up to 440 mA for a wide-range current measurement (for more information, refer to Recommended Operating Conditions).

8.2.1.3 Application Curve

The low on and off leakage currents of TMUX7219 and ultra-low charge injection performance make this device ideal for implementing high precision industrial systems. The TMUX7219 contains specialized architecture to reduce charge injection on the source (Sx) (see Section 7.3.7 for more details). Figure 8-2 shows the plot for the charge injection versus source voltage for the TMUX7219.

Figure 8-2. Charge Injection vs Source Voltage

8.2.2 Ultrasonic Sensing Gas Meter

Another application of the TMUX7219 is in the ultrasonic sensing gas meter. Ultrasonic sensing of gas flow uses the time of flight (ToF) of an ultrasonic wave and its dependency and behavior in the medium using two transducer pairs for upstream and downstream paths. Figure 8-3 shows a circuit example utilizing the MSP430FR6043 MCU, high voltage low distortion operational amplifiers (THS3091), along with TMUX7219, 2:1 precision switches. The TMUX7219 are needed to select the Rx and Tx path of the transducer. The TMUX7219 offers low on-state resistance and causes a very low signal distortion. The break-before-make feature allows transferring of a signal from one port to another, with a minimal signal distortion. This device also offers a low charge injection which makes this device suitable for high-performance audio and data acquisition systems.

Product Folder Links: *TMUX7219*

Figure 8-3. Ultrasonic Sensing Gas Meter System

8.2.2.1 Design Requirements

For this design example, use the parameters listed in Table 8-2.

Table 8-2. Design Parameters

PARAMETERS	VALUES
Supply (V_{DD})	15 V
Supply (V_{SS})	−15 V
MUX I/O signal range	−15 V to 15 V (Rail-to-Rail)
Control logic thresholds	1.8 V compatiable (up to V_{DD})
EN	EN pulled high to enable the switch
Zero-flow drift (ZFD)	±250 ps (typical)
Single-shot standard deviation (STD)	<500 ps

8.2.2.2 Detailed Design Procedure

The TMUX7219 can operate without any external components except for the supply decoupling capacitors. All inputs passing through the switch must fall within the recommended operating conditions of the TMUX7219, including signal range and continuous current. For this design with a positive supply of 15 V on V_{DD} and negative supply of −15 V on V_{SS}, the signal range can be −15 V to +15 V and the maximum continuous current can be up to 440 mA, as shown in the *Recommended Operating Conditions*, for a wide-range current measurement. The TMUX7219 device is a bidirectional, single-pole double-throw (SPDT) switch that offers low on-resistance, low leakage, and low power. These features make this device suitable for portable and power sensitive applications such as ultrasonic gas metering systems. For a more detailed analysis of the ultrasonic flow transmitter system, refer to the reference design.

8.2.2.3 Application Curve

The TMUX7219 is capable of switching signals with minimal distortion because of the ultra-low leakage currents and excellent on-resistance flatness. Figure 8-4 shows how the on-resistance for the TMUX7219 varies with different supply voltages.

$T_A = 25°C$

Figure 8-4. On-Resistance vs Source or Drain Voltage

9 Power Supply Recommendations

The TMUX7219 operates across a wide supply range of ±4.5 V to ±22 V (4.5 V to 44 V in single-supply mode). The device also performs well with asymmetrical supplies such as V_{DD} = 12 V and V_{SS} = –5 V.

Power-supply bypassing improves noise margin and prevents switching noise propagation from the supply rails to other components. Good power-supply decoupling is important to achieve optimum performance. For improved supply noise immunity, use a supply decoupling capacitor ranging from 0.1 µF to 10 µF at both the V_{DD} and V_{SS} pins to ground. Place the bypass capacitors as close to the power supply pins of the device as possible using low-impedance connections. TI recommends using multi-layer ceramic chip capacitors (MLCCs) that offer low equivalent series resistance (ESR) and inductance (ESL) characteristics for power-supply decoupling purposes. For very sensitive systems, or for systems in harsh noise environments, avoiding the use of vias for connecting the capacitors to the device pins may offer superior noise immunity. The use of multiple vias in parallel lowers the overall inductance and is beneficial for connections to ground and power planes. Always ensure the ground (GND) connection is established before supplies are ramped.

Product Folder Links: *TMUX7219*

10 Layout

10.1 Layout Guidelines

When a PCB trace turns a corner at a 90° angle, a reflection can occur. A reflection occurs primarily because of the change of width of the trace. At the apex of the turn, the trace width increases to 1.414 times the width. This increase upsets the transmission-line characteristics, especially the distributed capacitance and self-inductance of the trace which results in the reflection. Not all PCB traces can be straight and therefore some traces must turn corners. Figure 10-1 shows progressively better techniques of rounding corners. Only the last example (BEST) maintains constant trace width and minimizes reflections.

Figure 10-1. Trace Example

Route high-speed signals using a minimum of vias and corners which reduces signal reflections and impedance changes. When a via must be used, increase the clearance size around it to minimize its capacitance. Each via introduces discontinuities in the signal's transmission line and increases the chance of picking up interference from the other layers of the board. Be careful when designing test points, through-hole pins are not recommended at high frequencies.

Figure 10-2 shows an example of a PCB layout with the TMUX7219. Some key considerations are as follows:

* For reliable operation, connect a decoupling capacitor ranging from 0.1 µF to 10 µF between VDD/VSS and GND. We recommend a 0.1 µF and 1 µF capacitor, placing the lowest value capacitor as close to the pin as possible. Make sure that the capacitor voltage rating is sufficient for the supply voltage.
* Keep the input lines as short as possible.
* Use a solid ground plane to help reduce electromagnetic interference (EMI) noise pickup.
* Do not run sensitive analog traces in parallel with digital traces. Avoid crossing digital and analog traces if possible, and only make perpendicular crossings when necessary.
* Using multiple vias in parallel will lower the overall inductance and is beneficial for connection to ground planes.

10.2 Layout Example

Figure 10-2. TMUX7219DGK Layout Example

11 Device and Documentation Support

11.1 Documentation Support

11.1.1 Related Documentation
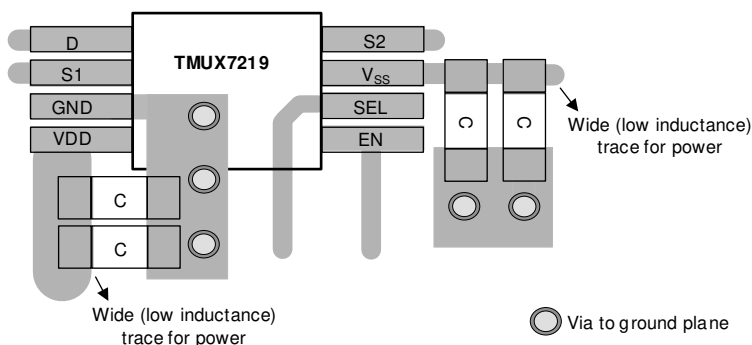
For related documentation, see the following:
- Texas Instruments, *Improve Stability Issues with Low CON Multiplexers* application brief
- Texas Instruments, *Improving Signal Measurement Accuracy in Automated Test Equipment* application brief
- Texas Instruments, *Multiplexers and Signal Switches Glossary* application report
- Texas Instruments, *QFN/SON PCB Attachment* application report
- Texas Instruments, *Quad Flatpack No-Lead Logic Packages* application report
- Texas Instruments, *Simplifying Design with 1.8 V logic Muxes and Switches* application brief
- Texas Instruments, *System-Level Protection for High-Voltage Analog Multiplexers* application report
- Texas Instruments, *True Differential, 4 x 2 MUX, Analog Front End, Simultaneous-Sampling ADC Circuit* application report
- Texas Instruments, *Ultrasonic sensing subsystem reference design for gas flow measurement* reference design

11.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

11.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

11.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.
All trademarks are the property of their respective owners.

11.5 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

11.6 Glossary

TI Glossary   This glossary lists and explains terms, acronyms, and definitions.

12 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision E (August 2022) to Revision F (July 2024)	Page
• Updated IIH specification...6	

Changes from Revision D (March 2022) to Revision E (August 2022)	Page
• Changed the status of the QFN package from: *preview* to: *active* 1	

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TMUX7219DGKR	Active	Production	VSSOP (DGK) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	X219
TMUX7219DGKR.B	Active	Production	VSSOP (DGK) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	X219
TMUX7219DGKRG4	Active	Production	VSSOP (DGK) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	X219
TMUX7219DGKRG4.B	Active	Production	VSSOP (DGK) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	X219
TMUX7219RQXR	Active	Production	WSON (RQX) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	H219
TMUX7219RQXR.B	Active	Production	WSON (RQX) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	H219

(1) Status: For more details on status, see our product life cycle.

(2) Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.
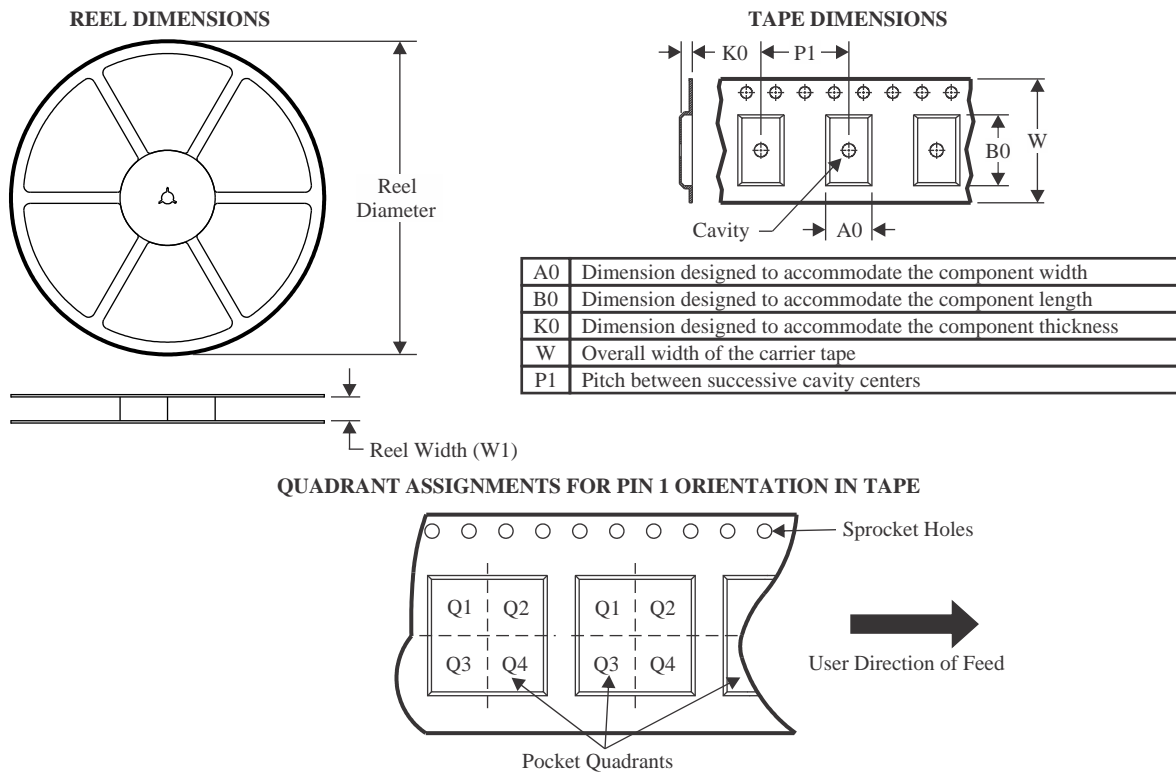
OTHER QUALIFIED VERSIONS OF TMUX7219 :

● Automotive : TMUX7219-Q1

NOTE: Qualified Version Definitions:

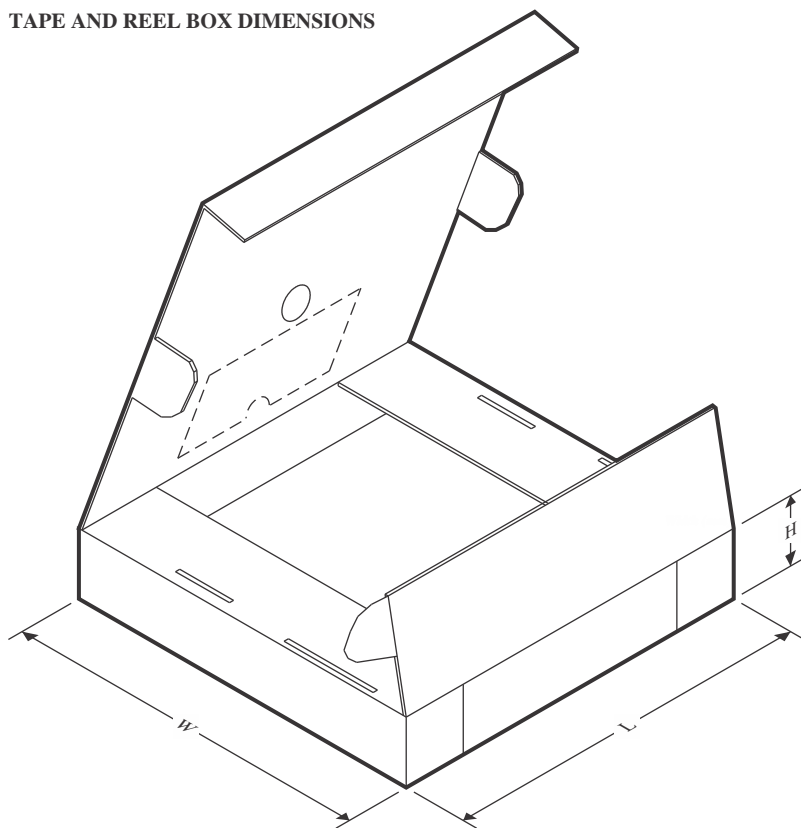   ● Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

![Texas Instruments logo]

PACKAGE MATERIALS INFORMATION

TAPE AND REEL INFORMATION

REEL DIMENSIONS

TAPE DIMENSIONS

A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TMUX7219DGKR	VSSOP	DGK	8	2500	330.0	12.4	5.25	3.35	1.25	8.0	12.0	Q1
TMUX7219DGKRG4	VSSOP	DGK	8	2500	330.0	12.4	5.25	3.35	1.25	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TMUX7219DGKR	VSSOP	DGK	8	2500	366.0	364.0	50.0
TMUX7219DGKRG4	VSSOP	DGK	8	2500	366.0	364.0	50.0

5.05
4.75 TYP

A

PIN 1 INDEX AREA

1

8

6X 0.65

2X

1.95

3.1
2.9
NOTE 3

4

5

8X 0.38
0.25

B

3.1
2.9
NOTE 4

⊕ 0.13Ⓜ C A B

C

⌒ 0.1 C

SEATING
PLANE

0.23
0.13

SEE DETAIL A

0.25
GAGE PLANE

1.1 MAX

0° -8°

0.7
0.4

0.15
0.05

DETAIL A
TYPICAL

4214862/A 04/2023

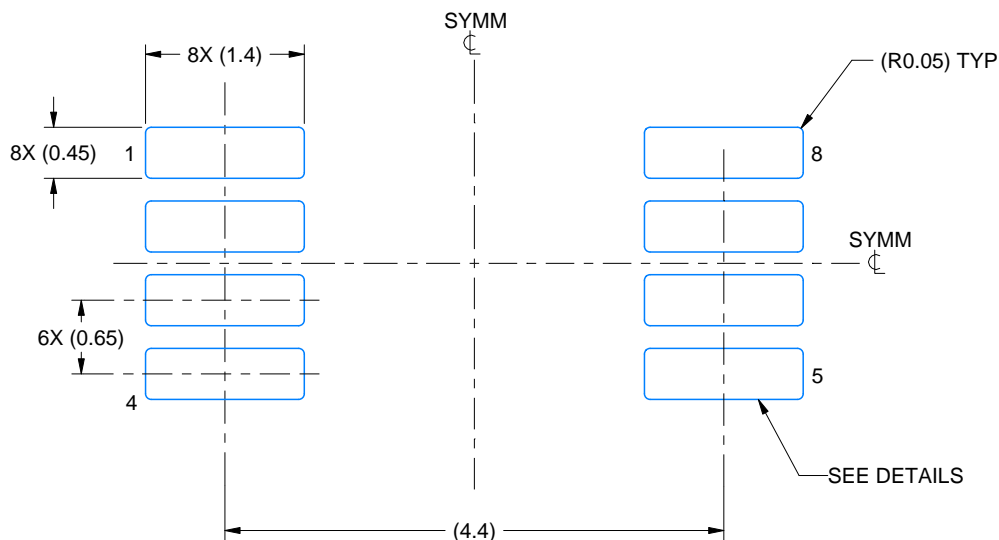PowerPAD is a trademark of Texas Instruments.

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187.

SYMM

8X (1.4)

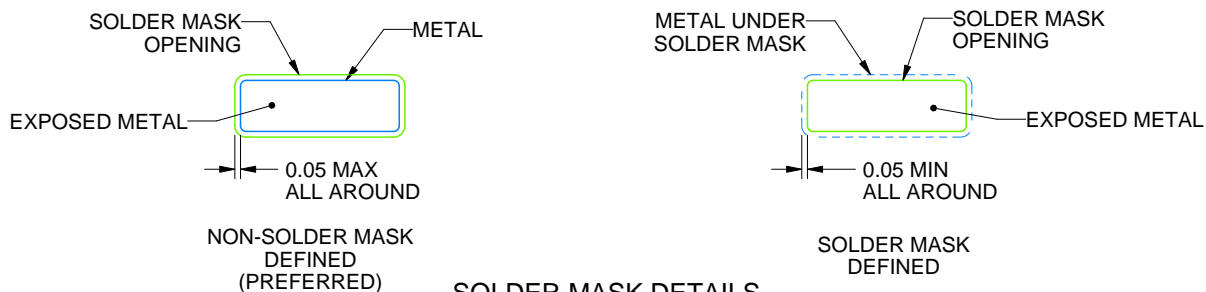8X (0.45) 1

(R0.05) TYP

8

SYMM

6X (0.65)

4

5

SEE DETAILS

(4.4)

LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 15X

SOLDER MASK
OPENING

METAL

EXPOSED METAL

0.05 MAX
ALL AROUND

NON-SOLDER MASK
DEFINED
(PREFERRED)

METAL UNDER
SOLDER MASK

SOLDER MASK
OPENING

EXPOSED METAL

0.05 MIN
ALL AROUND

SOLDER MASK
DEFINED

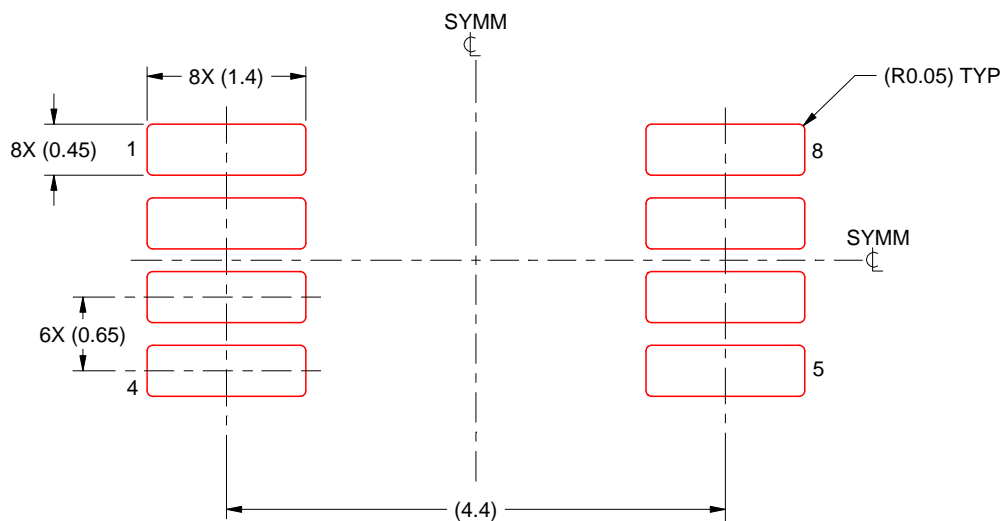SOLDER MASK DETAILS

4214862/A   04/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
9. Size of metal pad may vary due to creepage requirement.
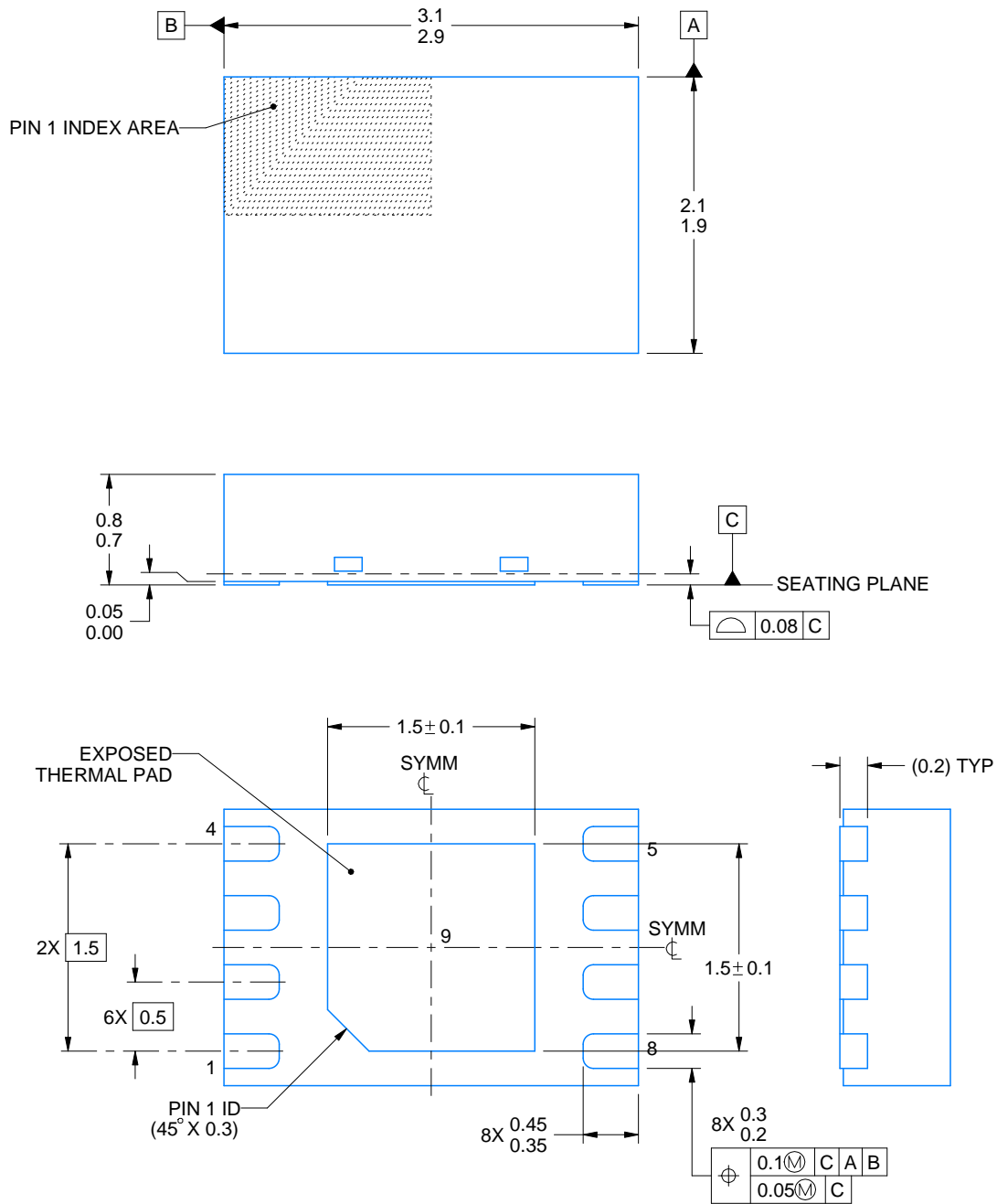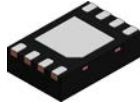
SOLDER PASTE EXAMPLE
SCALE: 15X

4214862/A   04/2023

NOTES: (continued)

11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate
design recommendations.
12. Board assembly site may have different recommendations for stencil design.

B | 3.1 / 2.9 | A

PIN 1 INDEX AREA

2.1 / 1.9

0.8 / 0.7

0.05 / 0.00

C

SEATING PLANE

⌒ 0.08 C

EXPOSED THERMAL PAD

1.5 ± 0.1

SYMM

4

5

2X 1.5

9

SYMM

1.5 ± 0.1

6X 0.5

1

8

PIN 1 ID
(45° X 0.3)

8X 0.45 / 0.35

8X 0.3 / 0.2

(0.2) TYP

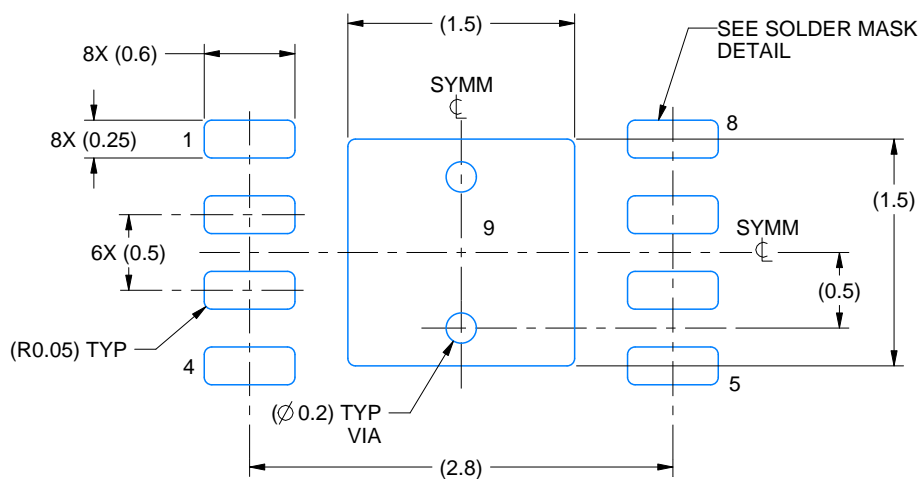⊕ | 0.1 Ⓜ | C A B
⊕ | 0.05 Ⓜ | C

4232251/A   09/2025

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.
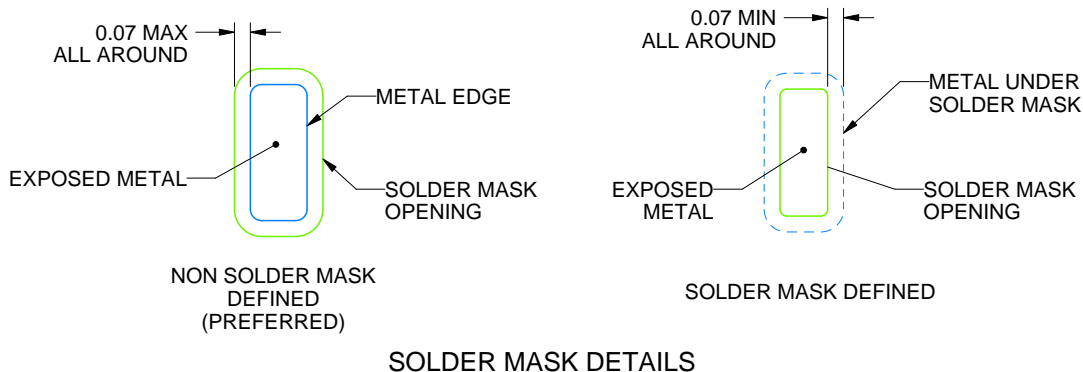
8X (0.6)

8X (0.25)

6X (0.5)

(R0.05) TYP

(1.5)

SYMM

SEE SOLDER MASK
DETAIL

8

9

(1.5)

SYMM

(0.5)

5

(Ø 0.2) TYP
VIA

(2.8)

LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 20X

0.07 MAX
ALL AROUND

METAL EDGE

EXPOSED METAL

SOLDER MASK
OPENING

NON SOLDER MASK
DEFINED
(PREFERRED)

0.07 MIN
ALL AROUND

METAL UNDER
SOLDER MASK

EXPOSED
METAL

SOLDER MASK
OPENING

SOLDER MASK DEFINED

SOLDER MASK DETAILS
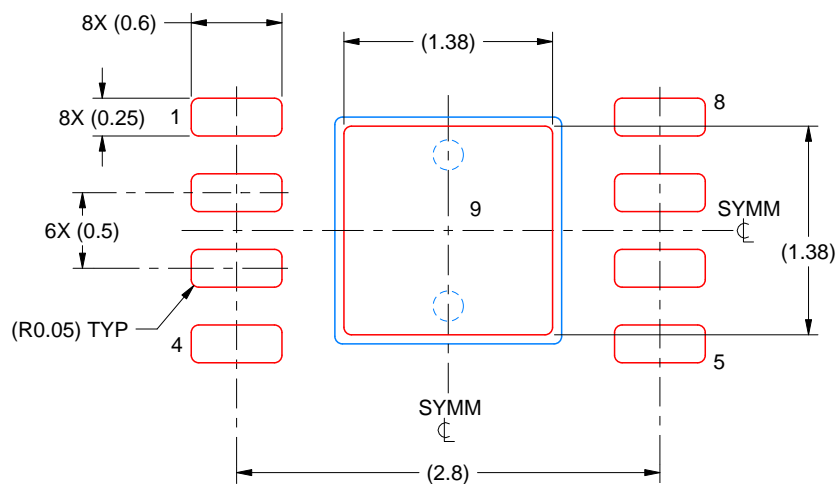
4232251/A   09/2025

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

8X (0.6)

8X (0.25)   1

(1.38)

8

6X (0.5)

9

SYMM
₵

(R0.05) TYP

(1.38)

4

5

SYMM
₵

(2.8)

SOLDER PASTE EXAMPLE
BASED ON 0.125 MM THICK STENCIL
SCALE: 20X

EXPOSED PAD 9
85% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE

4232251/A   09/2025

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate
   design recommendations.

B

3.1
2.9

A

PIN 1 INDEX AREA

2.1
1.9

0.8
0.7

C

0.05
0.00

SEATING PLANE

0.08 C

EXPOSED
THERMAL PAD

1.8 ± 0.1

SYMM

(0.2) TYP

4

5

2X 1.5

9

SYMM

1.65 ± 0.1

6X 0.5

8

1

PIN 1 ID

8X 0.45
0.35

8X 0.3
0.2

0.1 Ⓜ C A B
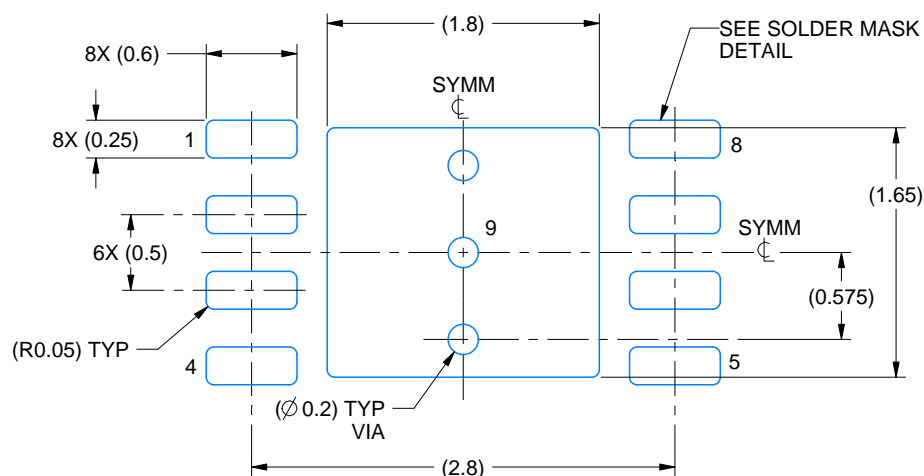0.05 Ⓜ

4225821/A   04/2020

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing
   per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

8X (0.6)

8X (0.25)   1
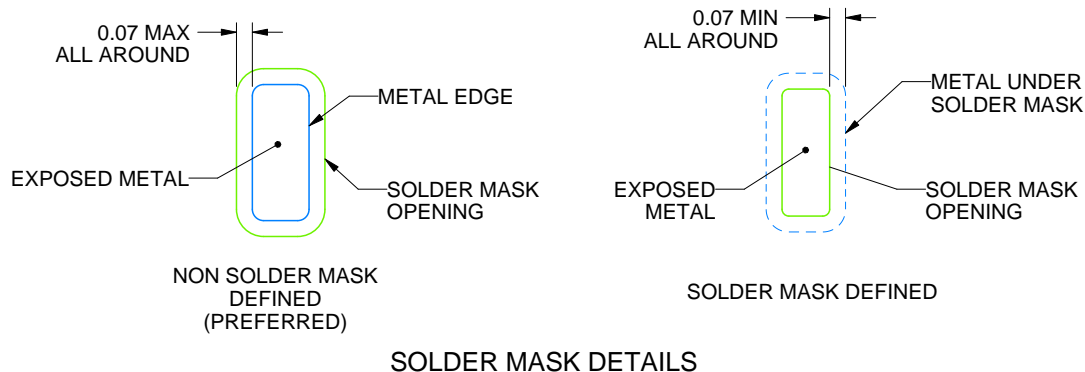
6X (0.5)

(R0.05) TYP

4

(Ø 0.2) TYP
VIA

(1.8)

SYMM

SEE SOLDER MASK
DETAIL

8

9   SYMM

(1.65)

(0.575)

5

(2.8)

LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 20X

0.07 MAX
ALL AROUND

METAL EDGE

EXPOSED METAL

SOLDER MASK
OPENING

NON SOLDER MASK
DEFINED
(PREFERRED)

0.07 MIN
ALL AROUND

METAL UNDER
SOLDER MASK

EXPOSED
METAL

SOLDER MASK
OPENING

SOLDER MASK DEFINED

SOLDER MASK DETAILS

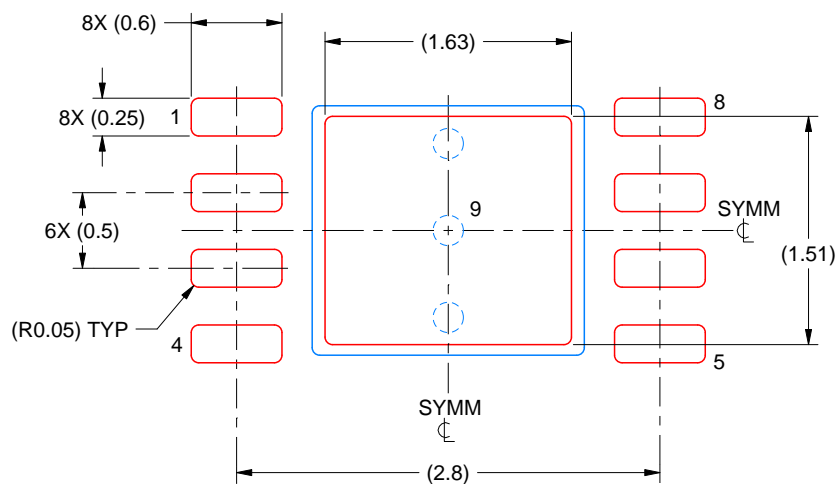4225821/A   04/2020

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

SOLDER PASTE EXAMPLE
BASED ON 0.125 MM THICK STENCIL
SCALE: 20X

EXPOSED PAD 9
83% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE

4225821/A   04/2020

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you fully indemnify TI and its representatives against any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale, TI's General Quality Guidelines, or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products. Unless TI explicitly designates a product as custom or customer-specified, TI products are standard, catalog, general purpose devices.

TI objects to and rejects any additional or different terms you may propose.